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TPCF8201

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOS III)

TPCF8201

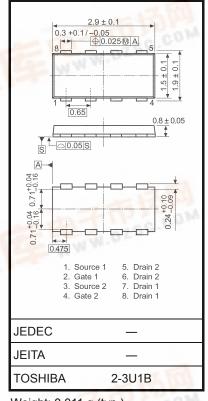
Notebook PC Applications Portable Equipment Applications

- Low drain-source ON resistance: R_{DS} (ON) = 38 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 5.4 \text{ S} (typ.)$
- Low leakage current: $I_{DSS} = 10 \ \mu A \ (max) \ (V_{DS} = 20 \ V)$
- Enhancement-mode: $V_{th} = 0.5 \text{ to } 1.2 \text{ V}$

 $(V_{DS} = 10 \text{ V}, \text{ ID} = 200 \text{ }\mu\text{A})$

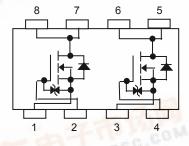
Absolute Maximum Ratings (Ta = 25°C)

Cha	Symbol	Rating	Unit		
Drain-source voltage	ge	V _{DSS}	20	V	
Drain-gate voltage	(R _{GS} = 20 kΩ)	V _{DGR}	20	V	
Gate-source voltag	je	V _{GSS}	±12	V	
Drain current	DC (Note 1)	ID	3	A	
Drain current	Pulse (Note 1)	I _{DP}	20 20 ±12	~	
Drain power dissipation	Single-device operation (Note 3a)	P _{D (1)}	1.35		
(t = 5 s) (Note 2a)	Single-device value at dual operation (Note 3b)	P _{D (2)}	1.12	W	
Drain power dissipation (t = 5 s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.53		
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.33	- 4	
Single pulse avala	nche energy (Note 4)	EAS	1.4 <mark>6</mark>	mJ	
Avalanche current	nche current				
Repetitive avalance Single-device value	EAR	0.11	mJ		
Channel temperatu	ire	T _{ch}	150	°C	
Storage temperatu	T _{stg}	-55~150	°C		



Weight: 0.011 g (typ.)

Circuit Configuration



Note: For Notes 1 to 6, refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with caution.



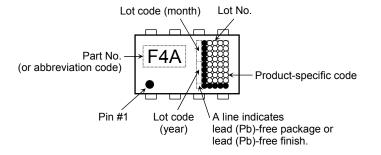
Unit: mm

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Thermal Characteristics

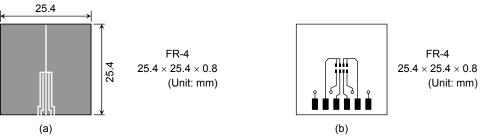
Charae	Symbol	Max	Unit		
Thermal resistance, channel to ambient (t = 5 s) (Note 2a)	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	92.6	°C/W	
	Single-device value at dual operation (Note 3b)	R _{th (ch-a)} (2)	111.6		
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	235.8	°C/W	
(t = 5 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	378.8	C/W	

Marking (Note 5)



Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)



(b) Device mounted on a glass-epoxy board (b)

- Note 3: a) The power dissipation and thermal resistance values are shown for a single device. (During single-device operation, power is only applied to one device.)
 - b) The power dissipation and thermal resistance values are shown for a single device. (During dual operation, power is evenly applied to both devices.)

Note 4: $V_{DD} = 16 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$ (initial), L = 0.5 mH, R_G = 25 Ω , I_{AR} = 1.5 A

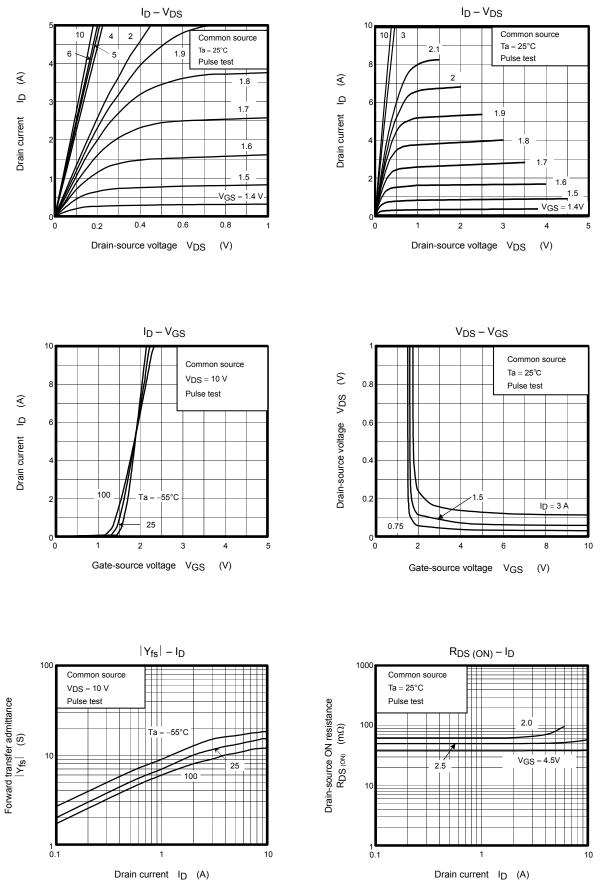
- Note 5: Repetitive rating: Pulse width limited by maximum channel temperature
- Note 6: " \bullet " on the lower left of the marking indicates Pin 1.

Electrical Characteristics (Ta = 25°C)

Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS}=\pm 10~V,~V_{DS}=0~V$	_		±10	μA
Drain cut-off curre	ent	I _{DSS}	$V_{DS} = 20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_	_	10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_{D} = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	20	_	_	V
Drain-source brea	akuown voltage	V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -12 \text{ V}$	8	—	_	v
Gate threshold vo	oltage	V _{th}	$V_{DS}=10~V,~I_D=200~\mu A$	0.5		1.2	V
		R _{DS (ON)}	$V_{GS} = 2.0 \text{ V}, \text{ I}_{D} = 1.5 \text{ A}$		62	100	
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = 2.5 \text{ V}, \ I_D = 1.5 \text{ A}$		50	66	mΩ
		R _{DS (ON)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 1.5 \text{ A}$	_	38	49	
Forward transfer admittance		Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1.5 \text{ A}$	2.7	5.4		S
Input capacitance		C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		590	_	pF
Reverse transfer capacitance		C _{rss}		_	70		
Output capacitance		C _{oss}		_	85		
	Rise time	tr	$V_{GS} \xrightarrow{5 \vee}_{0 \vee} \xrightarrow{I_D = 1.5 \wedge}_{0 \vee} \xrightarrow{I_D \to 0} \xrightarrow{I_D = 1.5 \wedge}_{0 \vee} \xrightarrow{I_D \to 0} $	_	3.0	_	
Switching time	Turn-on time	t _{on}		_	7.5	_	• ns
Switching time	Fall time	t _f		_	4.4	_	
	Turn-off time	t _{off}	Duty \leq 1%, t _w = 10 µs	_	26	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 16$ V, $V_{GS} = 5$ V, $I_D = 3.0$ A		7.5	_	
Gate-source charge1		Q _{gs1}			1.3		nC
Gate-drain ("miller") charge		Q _{gd}		_	2.1	_	

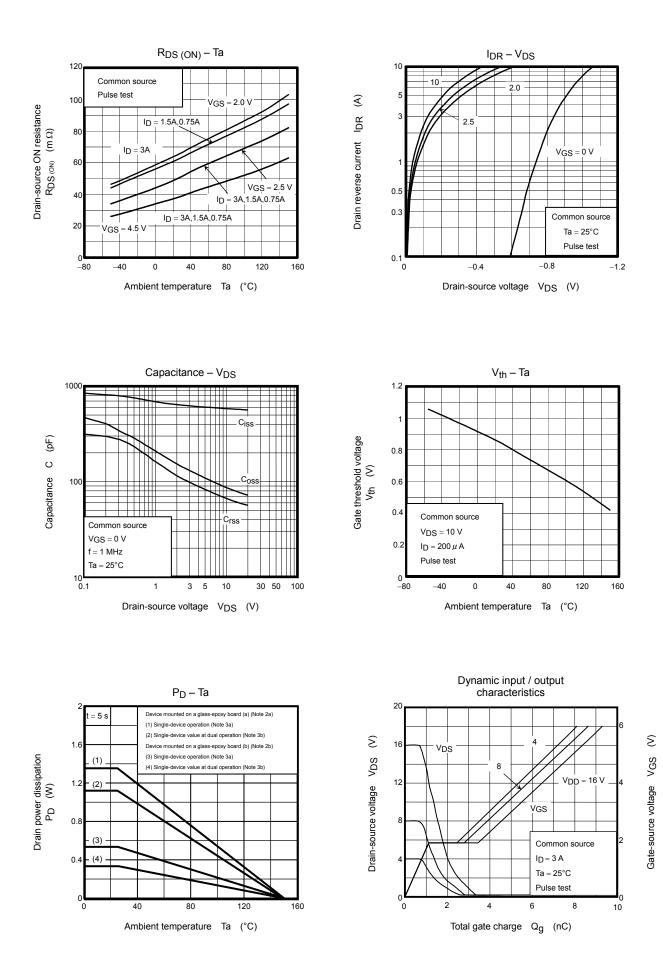
Source-Drain Ratings and Characteristics (Ta = 25°C)

Characterist	ics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	—	_		12	А
Forward voltage (diode)		V _{DSF}	$I_{DR} = 3.0 \text{ A}, V_{GS} = 0 \text{ V}$		_	-1.2	V

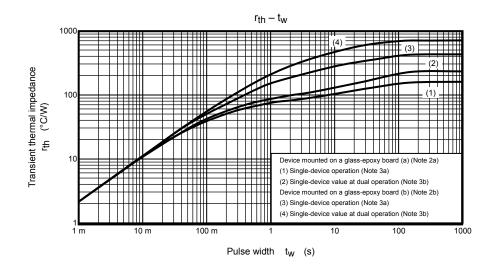


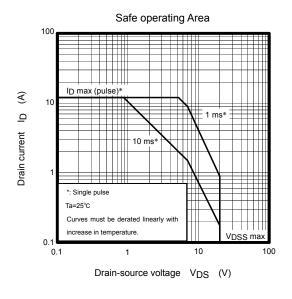
Drain current ID (A)

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Handbook" etc.

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